

# UNISONIC TECHNOLOGIES CO., LTD

# UF05N20

Preliminary

# 0.5A, 200V N-CHANNEL POWER MOSFET

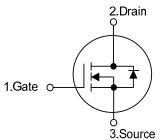
## DESCRIPTION

The UTC **UF05N20** is a high voltage power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.



- \* R<sub>DS(ON)</sub> < 2.8Ω @ V<sub>GS</sub>=10V, I<sub>D</sub>=0.25A
- \* High switching speed
- \* 100% avalanche tested

#### SYMBOL

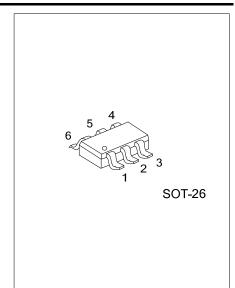


# ORDERING INFORMATION

Ordering Number	Package	Pin Assignment					Dooking	
		1	2	3	4	5	6	Packing
UF05N20G-AG6-R	SOT-26	D	D	G	S	D	D	Tape Reel
Note: Pin Assignment: G: Gate D: Drain S: Source								
UF05N20 <u>G-AG6-Ŗ</u>								
(1)Packing Type	(1) R: Tape Reel							
(2)Package Type	(2) AG6: SOT-26							
(3)Green Package	(3) G: Halogen Free and Lead Free							

# MARKING





#### ■ ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> =25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V <sub>DSS</sub>	200	V	
Gate-Source Voltage		V <sub>GSS</sub>	±20	V	
Continuous Drain Current	Continuous	I <sub>D</sub>	0.5	А	
	Pulsed	I <sub>DM</sub>	2.0	А	
Avalanche Current (Note 2)		I <sub>AR</sub>	0.85	А	
Avalanche Energy		E <sub>AS</sub>	19.86	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	2.3	V/ns	
Power Dissipation		PD	0.3	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature Range		T <sub>STG</sub>	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L=55mH, I<sub>AS</sub>=0.85A, V<sub>DD</sub>=50V, R<sub>G</sub>=25  $\Omega$ , Starting T<sub>J</sub> = 25°C

4. I\_{SD} ≤ 0.5A, di/dt ≤ 200A/µs, V\_{DD} ≤ BV\_{DSS}, Starting T\_J = 25°C

#### THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ <sub>JA</sub>	416	°C/W
Junction to Case	θις	110	°C/W

#### ■ ELECTRICAL CHARACTERISTICS (T<sub>A</sub> =25°C, unless otherwise specified)

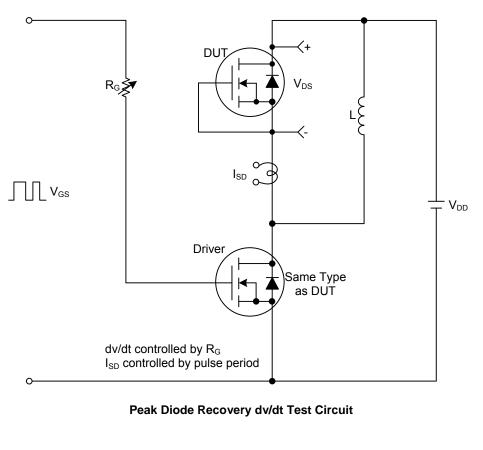
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	I <sub>D</sub> =250μΑ, V <sub>GS</sub> =0V	200			V
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =200V			1	μA
Gate-Source Leakage Current	Forward		V <sub>GS</sub> =+20V, V <sub>DS</sub> =0V			10	μA
	Reverse	I <sub>GSS</sub>	V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V			-10	μA
ON CHARACTERISTICS							
Gate Threshold Voltage		V <sub>GS(TH)</sub>	I <sub>D</sub> =250μA	1.0		3.0	V
Static Drain-Source On-State Resis	Static Drain-Source On-State Resistance		V <sub>GS</sub> =10V, I <sub>D</sub> =0.25A			2.8	Ω
DYNAMIC PARAMETERS							
Input Capacitance		CISS			102		рF
Output Capacitance		Coss	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz		28		рF
Reverse Transfer Capacitance		C <sub>RSS</sub>			10		рF
SWITCHING PARAMETERS							
Total Gate Charge (Note 1)	tal Gate Charge (Note 1)		V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =1.3A		3.7		nC
Gate to Source Charge		$Q_{GS}$	$I_{G}=100 \mu A$ (Note 1, 2)		0.18		nC
Gate to Drain Charge			$I_G = 100 \mu A (100 \text{e} 1, 2)$		0.4		nC
Turn-ON Delay Time (Note 1)		t <sub>D(ON)</sub>			13.6		ns
Rise Time Turn-OFF Delay Time		t <sub>R</sub>	$V_{GS}$ =10V, $V_{DD}$ =30V, $R_{G}$ =25 $\Omega$ ,		19		ns
		t <sub>D(OFF)</sub>	I <sub>D</sub> =0.5A (Note 1, 2)		69.6		ns
Fall-Time		t⊨			53.6		ns
SOURCE- DRAIN DIODE RATING	S AND CHA	RACTERISTI	CS				
Maximum Body-Diode Continuous (	Current	ls				0.5	Α
Maximum Body-Diode Pulsed Curre	ent	I <sub>SM</sub>				2.0	Α
Prain-Source Diode Forward Voltage (Note 1)		V <sub>SD</sub>	I <sub>S</sub> =0.5A			1.3	V
Body Diode Reverse Recovery Time (Note 1)		t <sub>rr</sub>	I <sub>S</sub> =0.5A, V <sub>GS</sub> =0V,		15.2		ns
Body Diode Reverse Recovery Charge		Q <sub>rr</sub>	dI <sub>F</sub> /dt = 100A/µs		24		nC
Notes: 1. Dulas Test: Dulas width < 200 us. Duty such < $20\%$							

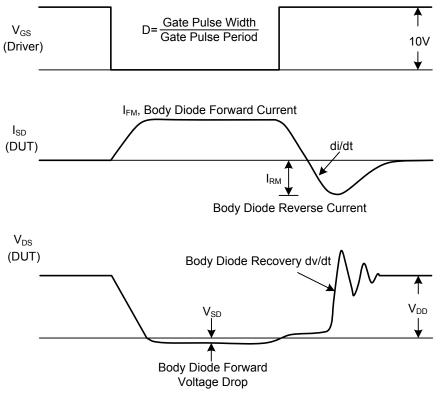
Notes: 1. Pulse Test: Pulse width  $\leq$  300µs, Duty cycle  $\leq$  2%.

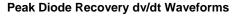
2. Essentially independent of operating temperature.



## ■ TEST CIRCUITS AND WAVEFORMS

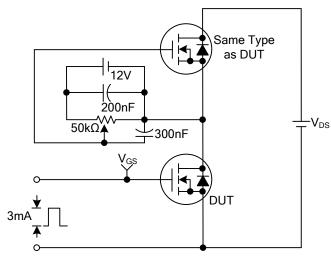




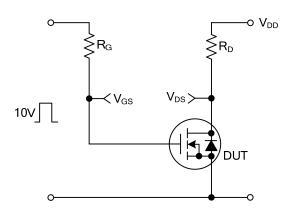




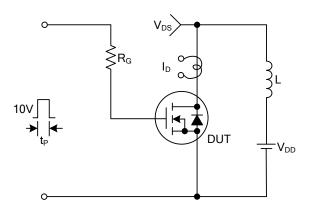
#### TEST CIRCUITS AND WAVEFORMS



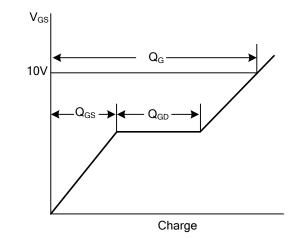
Gate Charge Test Circuit



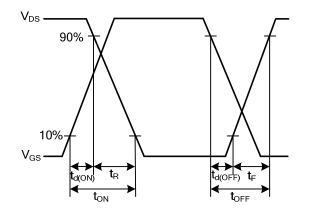
Resistive Switching Test Circuit



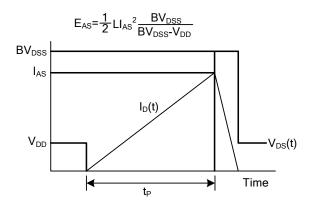
Unclamped Inductive Switching Test Circuit



Gate Charge Waveforms



Resistive Switching Waveforms



Unclamped Inductive Switching Waveforms



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